

Supertex inc. - OBSOLETE - TN0635 TN0640

Low Threshold



N-Channel Enhancement-Mode Vertical DMOS FETs

Ordering Information

BV _{DSS} / BV _{DGS}	R _{DS(ON)} (max)	I _{D(ON)} (min)	V _{GS(th)} (max)	Order Number / Package	
				TO-92	Die [†]
350V	10Ω	1.0A	1.8V	TN0635N3	TN0635ND
400V	10Ω	1.0A	1.8V	TN0640N3	TN0640ND

[†] MIL visual screening available

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Features

- Low threshold —1.8V max.
- High input impedance
- Low input capacitance — 85pF typical
- Fast switching speeds
- Low on resistance
- Free from secondary breakdown
- Low input and output leakage
- Complementary N- and P-channel devices

Low Threshold DMOS Technology

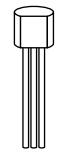
These low threshold enhancement-mode (normally-off) transistors utilize a vertical DMOS structure and Supertex's well-proven silicon-gate manufacturing process. This combination produces devices with the power handling capabilities of bipolar transistors and with the high input impedance and positive temperature coefficient inherent in MOS devices. Characteristic of all MOS structures, these devices are free from thermal runaway and thermally-induced secondary breakdown.

Supertex's vertical DMOS FETs are ideally suited to a wide range of switching and amplifying applications where very low threshold voltage, high breakdown voltage, high input impedance, low input capacitance, and fast switching speeds are desired.

Applications

- Logic level interfaces – ideal for TTL and CMOS
- Solid state relays
- Battery operated systems
- Photo voltaic drives
- Analog switches
- General purpose line drivers
- Telecom switches

Package Options



SGD
TO-92

Absolute Maximum Ratings

Drain-to-Source Voltage	BV _{DSS}
Drain-to-Gate Voltage	BV _{DGS}
Gate-to-Source Voltage	± 20V
Operating and Storage Temperature	-55°C to +150°C
Soldering Temperature*	300°C

* Distance of 1.6 mm from case for 10 seconds.

Note: See Package Outline section for dimensions.

Thermal Characteristics

Package	I_D (continuous)*	I_D (pulsed)	Power Dissipation @ $T_C = 25^\circ\text{C}$	θ_{jc} °C/W	θ_{ja} °C/W	I_{DR}^*	I_{DRM}
TO-92	200mA	1.5A	1.0W	125	170	200mA	1.5A

* I_D (continuous) is limited by max rated T_j .

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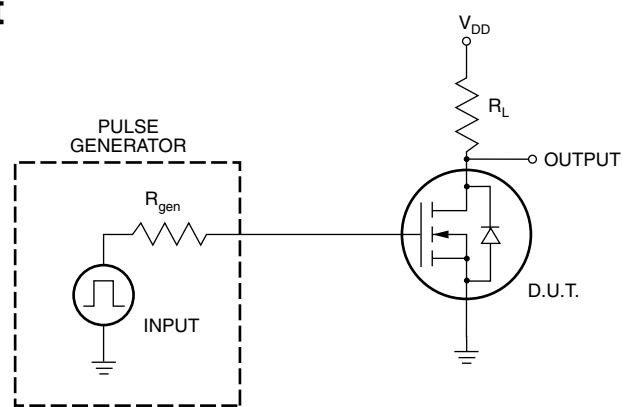
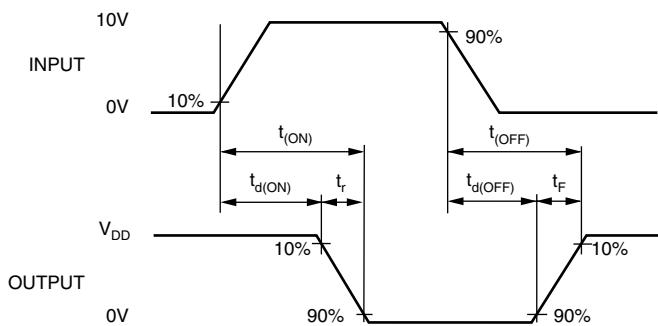
Electrical Characteristics (@ 25°C unless otherwise specified)

Symbol	Parameter	Min	Typ	Max	Unit	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	400			V	$V_{GS} = 0V, I_D = 100\mu\text{A}$
		350				
$V_{GS(\text{th})}$	Gate Threshold Voltage	0.6		1.8	V	$V_{GS} = V_{DS}, I_D = 1\text{mA}$
$\Delta V_{GS(\text{th})}$	Change in $V_{GS(\text{th})}$ with Temperature		-2.5	-4.0	mV/°C	$V_{GS} = V_{DS}, I_D = 1\text{mA}$
I_{GSS}	Gate Body Leakage			100	nA	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$
I_{DSS}	Zero Gate Voltage Drain Current			10	μA	$V_{GS} = 0V, V_{DS} = \text{Max Rating}$
				1.0	mA	$V_{GS} = 0V, V_{DS} = 0.8 \text{ Max Rating}$ $T_A = 125^\circ\text{C}$
$I_{D(\text{ON})}$	ON-State Drain Current	0.3	1.5		A	$V_{GS} = 5\text{V}, V_{DS} = 25\text{V}$
		1.0	1.8			$V_{GS} = 10\text{V}, V_{DS} = 25\text{V}$
$R_{DS(\text{ON})}$	Static Drain-to-Source ON-State Resistance		8.0	10	Ω	$V_{GS} = 4.5\text{V}, I_D = 150\text{mA}$
			7.0	10		$V_{GS} = 10\text{V}, I_D = 500\text{mA}$
$\Delta R_{DS(\text{ON})}$	Change in $R_{DS(\text{ON})}$ with Temperature			0.75	%/°C	$V_{GS} = 10\text{V}, I_D = 500\text{mA}$
G_{FS}	Forward Transconductance	125	350		$\text{m}\Omega$	$V_{DS} = 25\text{V}, I_D = 100\text{mA}$
C_{ISS}	Input Capacitance		85	130	pF	$V_{GS} = 0V, V_{DS} = 25\text{V}$ $f = 1 \text{ MHz}$
C_{OSS}	Common Source Output Capacitance		30	75		
C_{RSS}	Reverse Transfer Capacitance		10	20		
$t_{d(\text{ON})}$	Turn-ON Delay Time			20	ns	$V_{DD} = 25\text{V},$ $I_D = 1.0\text{A},$ $R_{\text{GEN}} = 25\Omega$
t_r	Rise Time			15		
$t_{d(\text{OFF})}$	Turn-OFF Delay Time			25		
t_f	Fall Time			20		
V_{SD}	Diode Forward Voltage Drop			1.8	V	$V_{GS} = 0V, I_{SD} = 200\text{mA}$
t_{rr}	Reverse Recovery Time		300		ns	$V_{GS} = 0V, I_{SD} = 1.0\text{A}$

Notes:

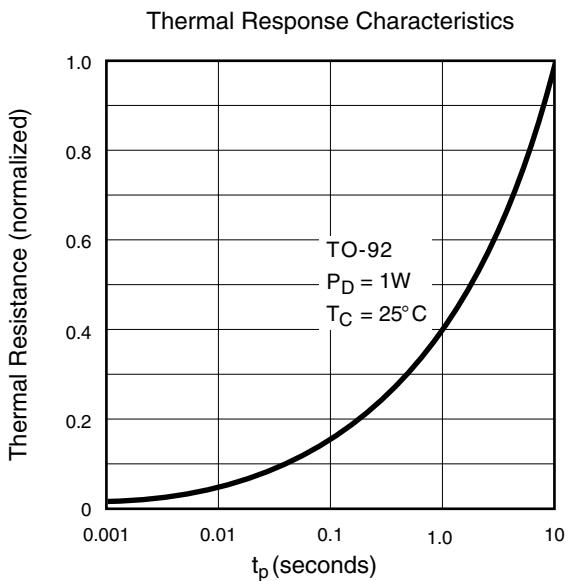
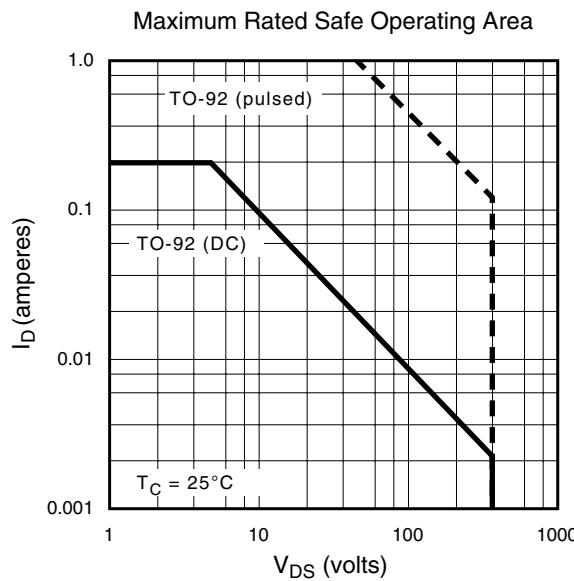
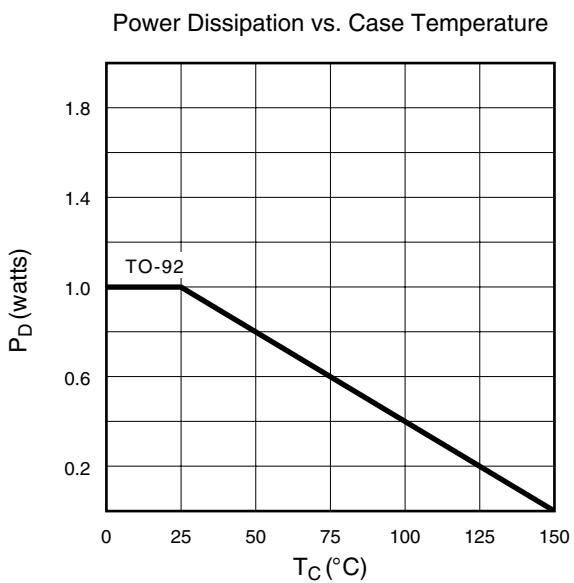
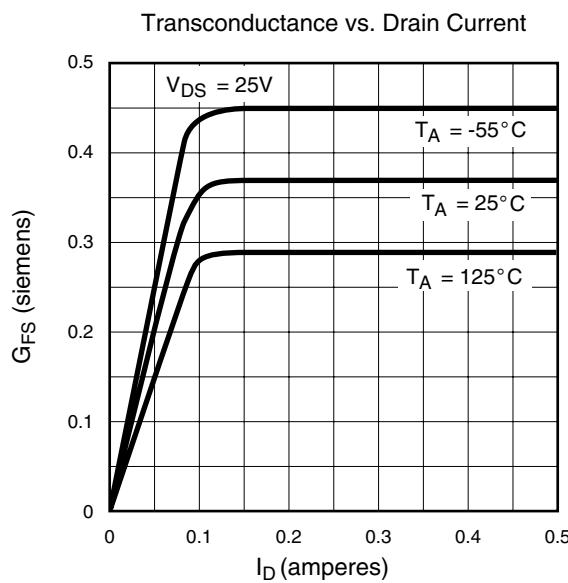
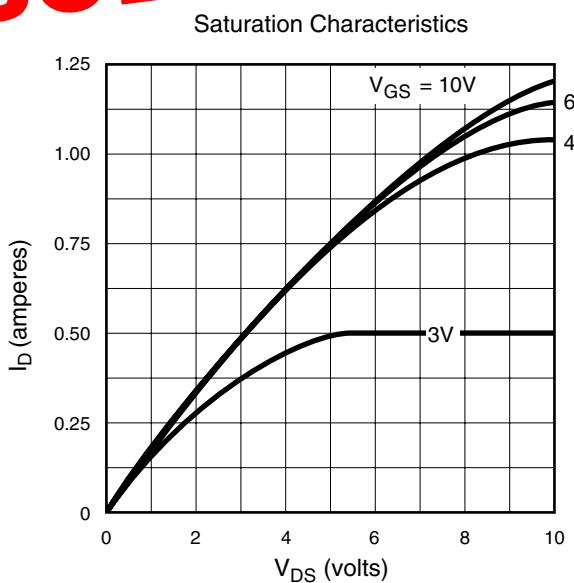
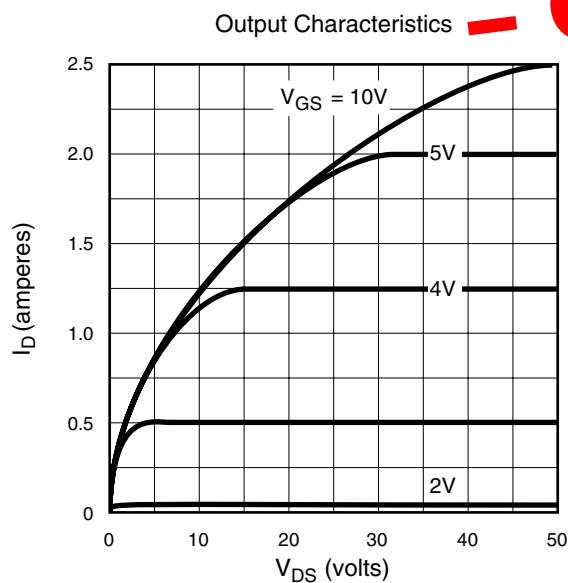
- All D.C. parameters 100% tested at 25°C unless otherwise stated. (Pulse test: 300μs pulse, 2% duty cycle.)
- All A.C. parameters sample tested.

Switching Waveforms and Test Circuit



Typical Performance Curves

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Typical Performance Curves

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